

Supporting Information in the manuscript

BiScO₃: centrosymmetric BiMnO₃-type oxide

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Synthesis. Stoichiometric mixtures of Bi_2O_3 and Sc_2O_3 were dried at 873 K for 8 h and then placed in Au capsules and treated at 6 G Pa in a belt-type high pressure apparatus at 1413 K for 40 min. After heat treatment, the samples were quenched to room temperature (RT), and the pressure was slowly released. BiScO_3 was recovered from a Au capsule in the form of powder. BiScO_3 was white. BiScO_3 contained small amount of Sc_2O_3 according to X-ray powder diffraction data.

X-ray Powder Diffraction (XRD) Experiments. XRD data of BiScO_3 were collected at room temperature on a RIGAKU Ultima III diffractometer using $\text{CuK}\alpha$ radiation (2θ range of 4–100°, a step width of 0.02°, and a counting time of 10 s/step).

Neutron Powder Diffraction Experiments and Structure Refinements. Neutron powder diffraction data of BiScO_3 were collected at room temperature with the high-resolution powder diffractometer (HRPD) installed at the JRR-3M reactor in JAERI, Tokai. The incident neutron wavelength was 1.8233(10) Å. About 4.66 g of the sample was contained in a V holder (diameter: 6.0 mm). The holder was slowly oscillated during the measurement. The data were taken with a step of ca. 0.05° in a 2θ range between 2.5 and 162° with 64 ^3He detectors. The measurement time was 18 h.

Neutron powder diffraction data were analyzed by the Rietveld method with RIETAN-2000.¹ The background was represented by a 9th-order Legendre polynomial. The split pseudo-Voigt function of Toraya² was used as a profile function. Isotropic atomic displacement parameters, U , with the isotropic Debye–Waller factor represented as $\exp(-8\pi^2 U \sin^2 \theta / \lambda^2)$ were assigned to all the sites. Bound coherent scattering lengths, b_c , used for the structure refinement were 8.532 fm (Bi), 12.290 fm (Sc), and 5.803 fm (O).³

For the impurity of Sc_2O_3 , we refined only a scale factor and the a lattice parameter, fixing its structure parameters. The mass percentage of Sc_2O_3 in BiScO_3 was calculated at 0.3 % from the refined scale factors.

Electron Diffraction. The electron diffraction patterns were obtained using an ultra-high-voltage transmission electron microscope (Hitachi H-1500) operated at an accelerating voltage of 820 kV. The TEM specimens were prepared by crushing the synthesized samples into fine fragments, which were ultrasonically dispersed in CCl_4 and transferred to carbon microgrids.

Second-Harmonic Generation (SHG) Experiments. SHG responses of powder samples were measured in a reflection scheme. A Q-switch pulsed Nd:YAG laser operated at $\lambda_{\omega} = 1064$ nm was used as a radiation source with a repetition rate of 4 impulses/s and a duration of impulses of about 12 ns. The laser beam was split into two beams to excite the radiation at a doubled frequency, $\lambda_{2\omega}$, of 532 nm simultaneously in samples to be measured and a reference sample: polycrystalline α -SiO₂. The incident-beam peak power was about 0.1 MW on a spot 3 mm in diameter on the surface of the sample.

Table S1. Selected Bond Lengths, l (Å), and Bond Valence Sums, BVS ,⁴ in BiScO₃ in space group $C2/c$

Bonds	l and BVS
Bi – O3	2.154(3)
Bi – O2	2.193(3)
Bi – O1	2.246(3)
Bi – O1a	2.553(3)
Bi – O3a	2.897(3)
Bi – O2a	3.019(3)
Bi – O3b	3.036(3)
Bi – O2b	3.257(3)
$BVS(\text{Bi})$	2.89
Sc1 – O2 (×2)	2.086(3)
Sc1 – O1 (×2)	2.110(3)
Sc1 – O3 (×2)	2.157(3)
$BVS(\text{Sc1})$	2.91
Sc2 – O3 (×2)	2.096(3)
Sc2 – O1 (×2)	2.117(3)
Sc2 – O2 (×2)	2.136(3)
$BVS(\text{Sc2})$	2.92

**Table S2. Structure Parameters Determined for BiScO₃
at Room Temperature from Neutron Powder Diffraction Data in Space
Group *C2*^a**

Site	Wyckoff position	<i>x</i>	<i>y</i>	<i>z</i>	10 ² <i>U</i> (Å ²)
Bi1	4 <i>c</i>	0.1405(8)	−0.0470(19)	0.3913(6)	0.86(16)
Bi2	4 <i>c</i>	0.3683(8)	0.0824(18)	0.1205(8)	0.28(15)
Sc1 ^b	2 <i>a</i>	0.0	0.0	0.0	0.42(18)
Sc2	4 <i>c</i>	0.2469(7)	0.0036(24)	0.7484(7)	0.80(6)
Sc3	2 <i>b</i>	0.5	0.0043(9)	0.5	0.34(18)
O1	4 <i>c</i>	0.0874(9)	−0.0518(24)	0.8376(11)	0.8(3)
O2	4 <i>c</i>	0.4261(10)	0.0758(24)	0.6719(12)	1.4(3)
O3	4 <i>c</i>	0.1647(10)	0.3041(20)	0.6255(10)	1.0(2)
O4	4 <i>c</i>	0.3642(8)	0.2998(18)	0.4137(8)	−0.7(2)
O5	4 <i>c</i>	0.3431(10)	0.2440(20)	0.9171(10)	1.4(3)
O6	4 <i>c</i>	0.1546(8)	0.2414(19)	0.1041(8)	−0.3(2)

^a Space group *C2* (No 5); *Z* = 8; *a* = 9.8906(5) Å, *b* = 5.8222(3) Å, *c* = 10.0467(5) Å, and β = 108.303(3)°; *V* = 549.26(4) Å³. *R*_{wp} = 5.14 % (*S* = *R*_{wp}/*R*_e = 1.99), *R*_p = 3.82 %, *R*_B = 1.50 %, and *R*_F = 0.72 %. The occupation of all the sites is unity.

^b The Sc1 site was placed at the origin (*y* = 0) owing to the arbitrariness of setting the origin in the non-centrosymmetric space group of *C2*.

**Table S3. Structure Parameters Determined for BiScO₃
at Room Temperature from Neutron Powder Diffraction Data in Space
Group *Cc*^a**

Site	Wyckoff position	<i>x</i>	<i>y</i>	<i>z</i>	10 ² <i>U</i> (Å ²)
Bi1	4 <i>a</i>	0.1287(10)	0.1779(12)	0.1318(11)	1.0(2)
Bi2	4 <i>a</i>	0.8568(8)	0.1898(10)	0.3630(10)	0.1(2)
Sc1	4 <i>a</i>	−0.0037(11)	0.2478(3)	0.7489(10)	0.49(7)
Sc2 ^b	4 <i>a</i>	1/4	0.2508(12)	1/2	0.36(7)
O1	4 <i>a</i>	0.0702(11)	0.1786(15)	0.5787(14)	0.0(2)
O2	4 <i>a</i>	0.9084(13)	0.1998(20)	0.9124(15)	2.0(3)
O3	4 <i>a</i>	0.1507(15)	0.5356(20)	0.3767(13)	1.9(3)
O4	4 <i>a</i>	0.8302(12)	0.5263(14)	0.1436(10)	−0.9(2)
O5	4 <i>a</i>	0.3403(11)	0.5173(16)	0.1696(13)	0.8(3)
O6	4 <i>a</i>	0.6298(11)	0.5420(13)	0.3373(12)	−0.5(2)

^a Space group *Cc* (No 9); *Z* = 8; *a* = 9.8905(5) Å, *b* = 5.8222(3) Å, *c* = 10.0471(5) Å, and β = 108.299(3)°; *V* = 549.30(4) Å³. *R*_{wp} = 5.02 % (*S* = 1.94), *R*_p = 3.70 %, *R*_B = 1.33 %, and *R*_F = 0.56 %. The occupation of all the sites is unity.

^b The Sc2 site was placed at (1/4, *y*, 1/2) owing to the arbitrariness of setting the origin in the non-centrosymmetric space group of *Cc*.

The lower values of *R* factors of the *Cc* model (38 refined structure parameters) compared with those of *C2* model (39 refined structure parameters) can be explained by the fact that space group *Cc* is ‘closer’ to the real space group (*C2/c*) from the view point of reflection conditions. The lower values of *R* factors of the *Cc* model (38 refined structure parameters) compared with those of *C2/c* model (19 refined structure parameters) can be explained by the larger number of the refined structure parameters in the *Cc* model.

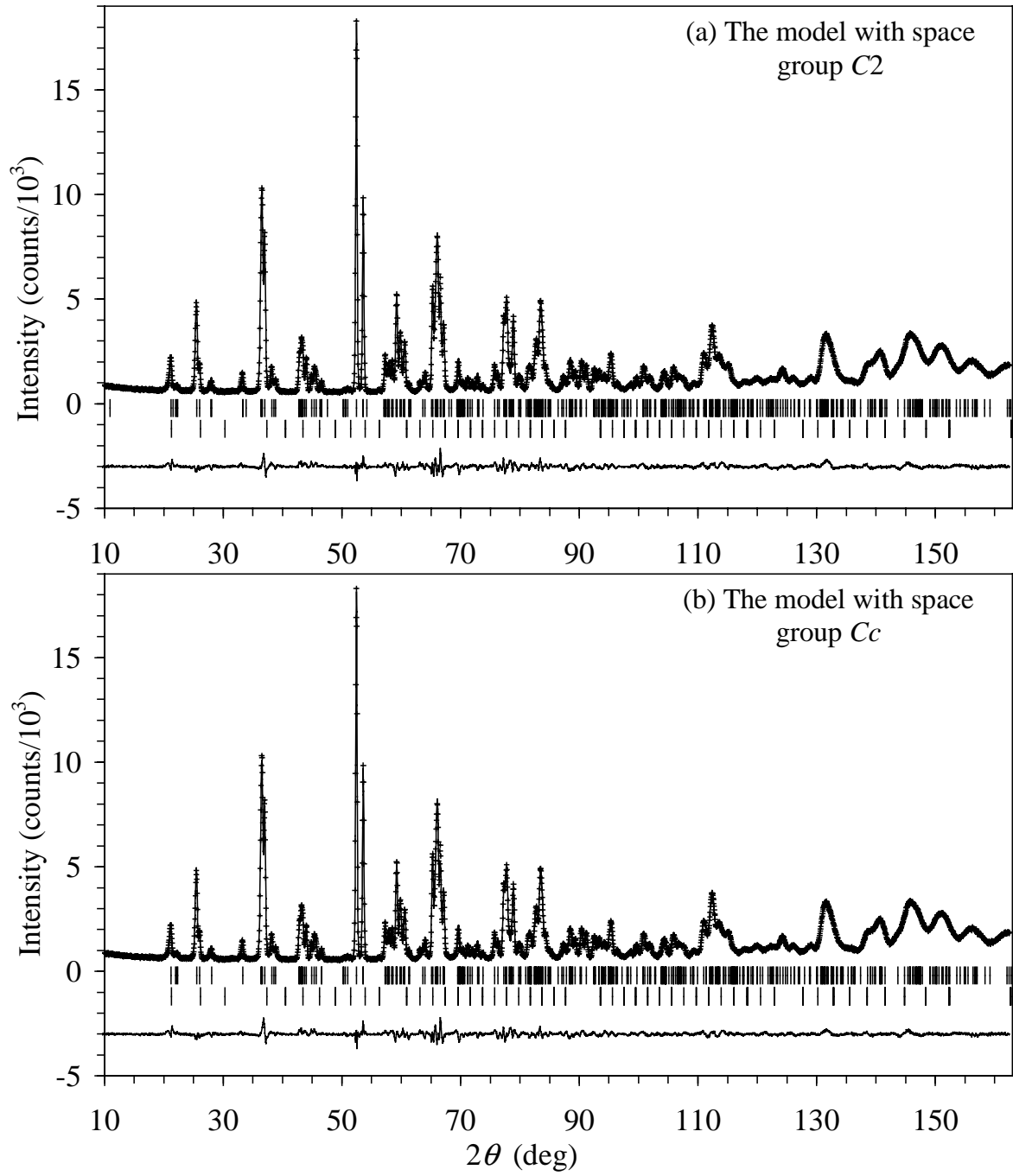


FIG. S1 Observed (crosses), calculated (solid line), and difference patterns resulting from the Rietveld analysis of the neutron powder diffraction data for BiScO_3 in space groups $C2$ and Cc . Bragg reflections are indicated by tick marks. The lower tick marks are given for the impurity phase, Sc_2O_3 .

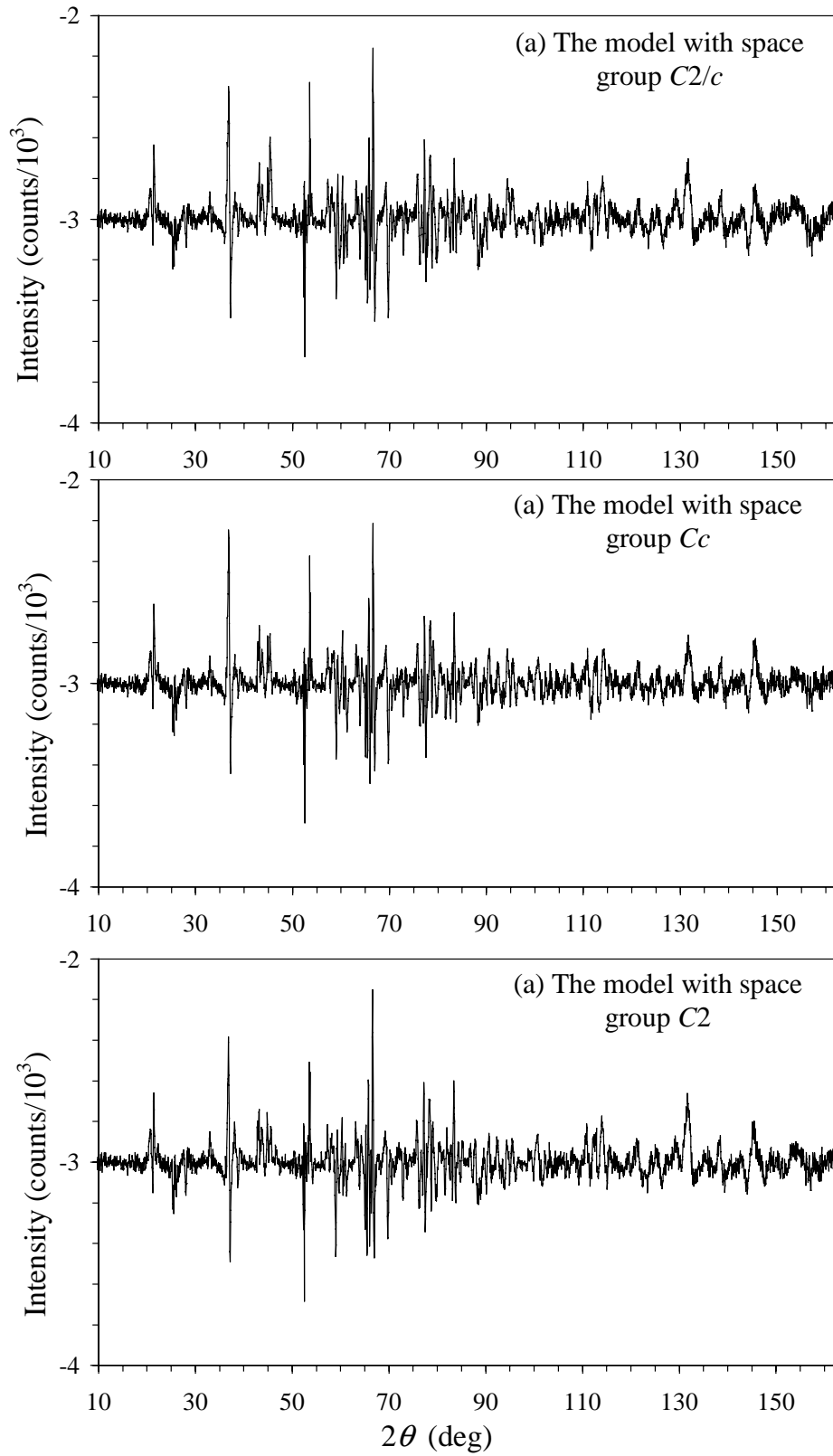


FIG. S2 Enlarged difference patterns resulting from the Rietveld analysis of the neutron powder diffraction data for BiScO_3 in space groups $C2/c$, Cc , and $C2$.

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